Application/Control No. Applicant(s)/Patent Under Reexamination 10/782,289 VAN DE VELDE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2851 Christopher E. Mahoney U.S. PATENT DOCUMENTS Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY Lu, Chang-Hsing 353/101 04-2002 US-2002/0044264 Α 396/55 US-5,659,806 08-1997 Miyamoto et al. В 353/101 US-6,773,117 08-2004 Watanabe, Takashi С 353/101 06-2004 Runco, Virgil Sam US-2004/0114115 D 353/101 12-2002 Tachibana, Toshitaka US-6,491,401 Ε F US-US-G USн 1 US-US-

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